TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

# TC7SL02F, TC7SL02FU

# 2-INPUT NOR GATE

The TC7SL02 is a low voltage operative C<sup>2</sup>MOS 2-INPUT NOR GATE fabricated with silicon gate C<sup>2</sup>MOS technology.

Operating voltage (V<sub>CC (opr)</sub>) is 1~3V equivalent to 1pc or 2pcs of dry cell battery and it achives low power dissipation.

The internal circuit is composed of 3 stages including buffer output, which enables high noise immunity and stable output.

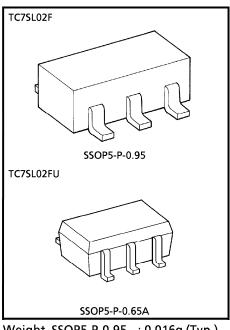
All inputs are equipped with protection circuits against static discharge or transient excess voltage.

#### **FEATURES**

•	High Speed ······	····· t <sub>pd</sub> = 10ns (Typ.)
		at $V_{CC} = 3V$

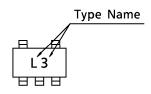
• Low Power Dissipation 
$$\cdots$$
 I<sub>CC</sub> =  $1\mu$ A (Max.) at Ta =  $25^{\circ}$ C

- Symmetrical Output Impedance ····· |I<sub>OH</sub>| = I<sub>OL</sub> = 1mA
- Balanced Propagation Delay Time  $\cdots t_{pLH} = t_{pHL}$
- Low Voltage Operating·············V<sub>CC</sub> (opr) = 1~3.6V



Weight SSOP5-P-0.95 : 0.016g (Typ.) SSOP5-P-0.65A : 0.006g (Typ.)

#### MARKING

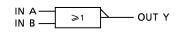


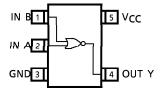
## **MAXIMUM RATINGS**

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage Range	Vcc	-0.5~5	V
DC Input Voltage	VIN	-0.5~V <sub>CC</sub> +0.5	V
DC Output Voltage	Vout	-0.5~V <sub>CC</sub> +0.5	V
Input Diode Current	ΊΚ	± 20	mA
Output Diode Current	loк	± 20	mA
DC Output Current	IOUT	± 12.5	mA
DC V <sub>CC</sub> / Ground Current	lcc	± 25	mA
Power Dissipation	PD	200	mW
Storage Temperature	T <sub>stq</sub>	-65~150	°C
Lead Temperature (10s)	Tı	260	°C

# LOGIC DIAGRAM

## **PIN CONNECTION (TOP VIEW)**





## RECOMMENDED OPERATING CONDITIONS

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage	Vcc	1~3.6	٧
Input Voltage	VIN	0~V <sub>CC</sub>	<b>\</b>
Output Voltage	Vout	0~V <sub>CC</sub>	<b>V</b>
Operating Temperature	T <sub>opr</sub>	- 40~85	°C
		$0 \sim 1000  (V_{CC} = 1.0V)$	
Input Rise and Fall Time	t <sub>r</sub> , t <sub>f</sub>	0∼ 500 (V <sub>CC</sub> = 1.5V)	ns
		0∼ 400 (V <sub>CC</sub> = 3.0V)	

#### DC ELECTRICAL CHARACTERISTICS

CHADACTERISTIC	CVMPOL	TEST	TEST CONDITION VCC		Ta = 25°C			Ta = -4			
CHARACTERISTIC	SYMBOL	CIR- CUIT			Vcc	MIN.	TYP.	MAX.	MIN.	MAX.	UNIT
High-Level Input			_		1.0	0.75	_	_	0.75	_	V
Voltage	VIH	—			1.5	1.05	_	—	1.05	—	
Voltage					3.0	2.10	_		2.10	_	
Low-Level Input			_		1.0	—	<u> </u>	0.25	—	0.25	
Voltage	V <sub>IL</sub>	—			1.5	—	<u> </u>	0.45	—	0.45	V
Voltage					3.0	_	_	0.90	_	0.90	
	V <sub>ОН</sub>			I <sub>OH</sub> = -20μA	1.0	0.9	1.0	—	0.9	—	V
High-Level			V <sub>IN</sub> = V <sub>IL</sub>		1.5	1.4	1.5	—	1.4	—	
Output Voltage		—			3.0	2.9	3.0	—	2.9	<b>—</b>	
Output voltage				$I_{OH} = -1mA$	1.5	1.07	1.23	—	0.99	—	
				$I_{OH} = -2.6mA$	3.0	2.61	2.68	—	2.55	_	
	V <sub>OL</sub>		V <sub>IN</sub> = V <sub>IH</sub>	I <sub>OL</sub> = 20μA	1.0	_	0.0	0.1	_	0.1	
Low-Level					1.5		0.0	0.1	—	0.1	
		—			3.0		0.0	0.1	—	0.1	V
Output Voltage			or V <sub>IL</sub>	I <sub>OL</sub> = 1mA	1.5	_	0.23	0.31	_	0.37	
					$I_{OL} = 2.6 mA$	3.0	_	0.23	0.31	—	0.33
Input Leakage Current	IN	_	V <sub>IN</sub> = V <sub>CC</sub>	or GND	3.6	_	_	± 0.1	_	± 1.0	^
Quiescent Supply Current	lcc	_	V <sub>IN</sub> = V <sub>CC</sub>	or GND	3.6	_	_	1.0	_	10.0	μΑ

CHARACTERISTIC		TEST CIR- CUIT	TEST CONDITION		Ta = 25°C			
CHARACTERISTIC			TEST CONDITION	MIN.	TYP.	MAX.	UNIT	
Output Transition	tTLH		_	_	5.0	9.0	ns	
Time	tTHL		_		3.0	3.0	113	
Propagation	t <sub>PLH</sub>				7.5	13.0	ns	
Delay Time	t <sub>PHL</sub>	_	_	_	/.5	13.0	113	

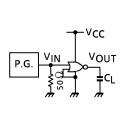
# AC ELECTRICAL CHARACTERISTICS ( $C_L = 25pF$ , Input $t_r = t_f = 6ns$ )

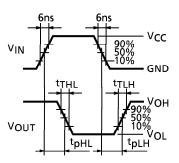
CHARACTERISTIC	SYMBOL	TEST	TEST CONDITION		Ta = 25°C			Ta = -4		
CHARACTERISTIC		CIR- CUIT		VCC	MIN.	TYP.	MAX.	MIN.	MAX.	UNIT
Output Transition	4			1.0	_	70	170	_	240	
Output Transition Time	t <sub>TLH</sub>	—	<u> </u>	1.5	l —	25	45	—	55	ns
Time	tTHL			3.0	—	10	15	—	20	
Dranagation	4			1.0	_	70	170	_	210	
Propagation Delay Time	t <sub>PLH</sub>	—	_	1.5	—	25	45	—	55	ns
Delay Time	<sup>t</sup> PHL			3.0	<b>—</b>	10	15	—	20	
Input Capacitance	C <sub>IN</sub>		_		_	5	10	_	10	
Power Dissipation Capacitance	C <sub>PD</sub>		Note (1)		_	10	_	_	_	pF

Note (1): C<sub>PD</sub> defined as the value of internal equivalent capacitance of IC which is calculated from the operating current consumption without load (refer to Test Circuit).

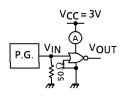
Average operating current can be obtained by the equation as follows.  $I_{CC \text{ (opr)}} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$ 

#### **SWITCHING CHARACTERISTICS TEST CIRCUIT**





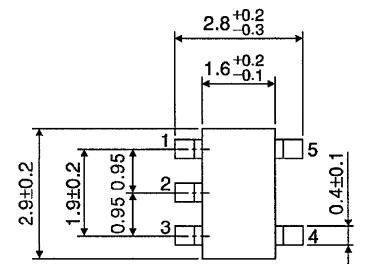
ICC (opr) TEST CIRCUIT

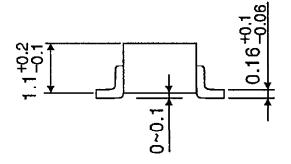


Input waveform is the same as that in case of switching characteristics test.

## PACKAGE DIMENSIONS SSOP5-P-0.95

Unit: mm



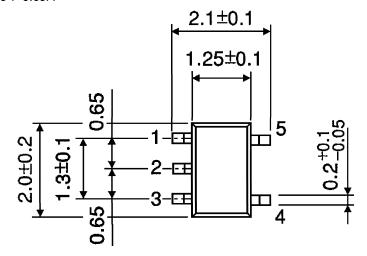


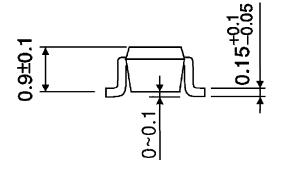
Weight: 0.016g (Typ.)

4 2001-05-31

## PACKAGE DIMENSIONS SSOP5-P-0.65A

Unit: mm





Weight: 0.006g (Typ.)

5 2001-05-31

#### RESTRICTIONS ON PRODUCT USE

000707EBA

- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property. In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc..
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- The products described in this document are subject to the foreign exchange and foreign trade laws.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA CORPORATION for any infringements of intellectual property or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any intellectual property or other rights of TOSHIBA CORPORATION or others.
- The information contained herein is subject to change without notice.

6 2001-05-31